

<b>Notice of References Cited</b>	Application/Control No. 10/539,188		Applicant(s)/Patent Under Reexamination ITO ET AL.	
	Examiner Matthew P. Coughlin		Art Unit 1626	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,874,890	10-1989	Kato et al.	560/256
*	B	US-4,591,626	05-1986	Kawai et al.	526/282
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Sajiki et al. Synlett. 2002, No. 7, 1149-1151
	V	Garnett et al. Aust. J. Chem. 1961, 14, 441-448
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.